

Search Notes

Application/Control No.

08/990,096

Examiner

Hanh Nguyen

Applicant(s)/Patent under
Reexamination

PICHER-DEMPSEY, HEIDI

Art Unit

2616

SEARCHED

| Class | Subclass | Date | Examiner |
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| 709 | 223 | 7/31/2006 | HN |
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| 370 | 230 | | |
| | 230.1 | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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